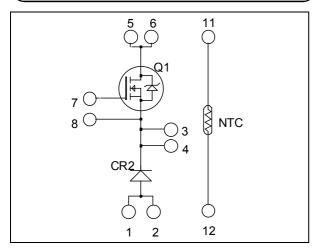
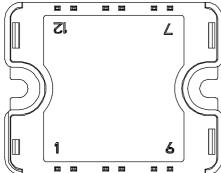


Buck chopper Super Junction MOSFET SiC chopper diode





Pins 1/2; 3/4; 5/6 must be shorted together

$$\begin{split} V_{DSS} &= 600V \\ R_{DSon} &= 24m\Omega \text{ max } @ \text{Tj} = 25^{\circ}\text{C} \\ I_D &= 95\text{A} @ \text{Tc} = 25^{\circ}\text{C} \end{split}$$

Application

- AC and DC motor control
- Switched Mode Power Supplies

Features

COOLMOS

Power Semiconductors

- Ultra low R_{DSon}
- Low Miller capacitance
- Ultra low gate charge
- Avalanche energy rated
- Very rugged

• CR2 SiC Schottky Diode

- Zero reverse recovery
- Zero forward recovery
- Temperature Independent switching behavior
- Positive temperature coefficient on VF
- Very low stray inductance
- Internal thermistor for temperature monitoring
- High level of integration

Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- RoHS Compliant

Absolute maximum ratings

Symbol	Parameter		Max ratings	Unit
$V_{ m DSS}$	Drain - Source Breakdown Voltage		600	V
Ţ	Continuous Drain Current	$T_c = 25$ °C	95	
I_D	Continuous Diani Current	$T_c = 80$ °C	70	Α
I_{DM}	Pulsed Drain current	260		
V_{GS}	Gate - Source Voltage	±20	V	
R_{DSon}	Drain - Source ON Resistance		24	mΩ
P_{D}	Maximum Power Dissipation	462	W	
I_{AR}	Avalanche current (repetitive and non repetitive)	15	Α	
E _{AR}	Repetitive Avalanche Energy		3	mJ
E_{AS}	Single Pulse Avalanche Energy		1900	1111

These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com



All ratings @ $T_j = 25^{\circ}C$ unless otherwise specified

Electrical Characteristics

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
I_{DSS}	Zero Gate Voltage Drain Current	$V_{GS} = 0V, V_{DS} = 600V$ $T_j = 25^{\circ}C$			350	μА
		$V_{GS} = 0V, V_{DS} = 600V$ $T_j = 125^{\circ}C$			600	
R _{DS(on)}	Drain – Source on Resistance	$V_{GS} = 10V, I_D = 47.5A$			24	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 5mA$	2.1	3	3.9	V
I_{GSS}	Gate – Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			200	nA

Dynamic Characteristics

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
Ciss	Input Capacitance	$V_{GS} = 0V ; V_{DS} = 25V$		14.4		nF
C_{oss}	Output Capacitance	f = 1MHz		17		111
Q_{g}	Total gate Charge	$V_{GS} = 10V$		300		
Q_{gs}	Gate – Source Charge	$V_{\text{Bus}} = 300 \text{V}$		68		nC
Q_{gd}	Gate – Drain Charge	$I_D = 95A$		102		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (125°C)		21		
$T_{\rm r}$	Rise Time	$V_{GS} = 10V$		30		
$T_{d(off)}$	Turn-off Delay Time	$\begin{array}{c} \hline V_{Bus} = 400V \\ I_D = 95A \\ R_G = 2.5\Omega \end{array}$		100		ns
T_{f}	Fall Time			45		
Eon	Turn-on Switching Energy	Inductive switching @ 25°C		810		μJ
E_{off}	Turn-off Switching Energy	$V_{GS} = 10V ; V_{Bus} = 400V$ $I_D = 95A ; R_G = 2.5\Omega$		1040		μυ
Eon	Turn-on Switching Energy	Inductive switching @ 125°C		1320		1
E_{off}	Turn-off Switching Energy	$V_{GS} = 10V ; V_{Bus} = 400V$ $I_D = 95A ; R_G = 2.5\Omega$		1270		μJ

CR2 SiC diode ratings and characteristics

Symbol	Characteristic	Test Condition:	Min	Typ	Max	Unit	
V_{RRM}	Maximum Peak Repetitive Reverse Voltage			600			V
I_{RM}	Maximum Reverse Leakage Current	$V_R=600V$	$T_j = 25$ °C		200	800	μA
1RM		VR 000 V	$T_j = 175$ °C		400	4000	μ1
I_F	DC Forward Current	Tc = 100°C			40		A
V_{F}	Diode Forward Voltage	$I_{\rm p} = 40\Delta$	$T_j = 25^{\circ}C$		1.6	1.8	V
V F			$T_j = 175$ °C		2.0	2.4	·
Qc	Total Capacitive Charge	$I_F = 40A, V_R = 300V$ di/dt = 1200A/ μ s			56		nC
С	Total Capacitance	$f = 1MHz, V_R = 200V$ $f = 1MHz, V_R = 400V$			260		ъE
					200		pF



Thermal and package characteristics

Symbol	Characteristic			Min	Тур	Max	Unit	
R_{thJC}	Junction to Case Thermal Resistance	,	Transis	stor				°C/W
1\(\text{thJC}\)			SiC Di	ode			0.8	C/W
V_{ISOL}	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz			4000			V	
T_{J}	Operating junction temperature range			-40		150		
T_{STG}	Storage Temperature Range			-40		125	°C	
$T_{\rm C}$	Operating Case Temperature				-40		100	
Torque	Mounting torque	To heatsi	nk	M4	2		3	N.m
Wt	Package Weight				80	g		

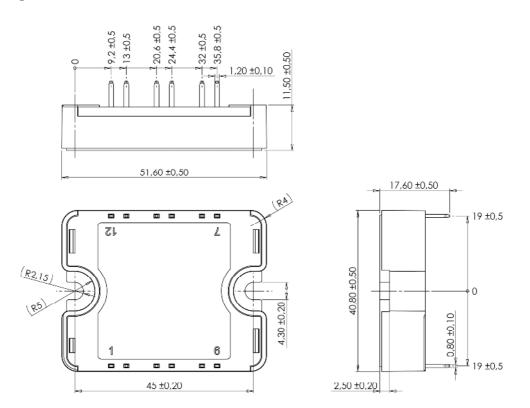
Temperature sensor NTC (see application note APT0406 on www.microsemi.com for more information).

Symbol	Characteristic		Min	Typ	Max	Unit
R ₂₅	Resistance @ 25°C			50		kΩ
$\Delta R_{25}/R_{25}$				5		%
$B_{25/85}$	$T_{25} = 298.15 \text{ K}$			3952		K
$\Delta B/B$		T _C =100°C		4		%

$$R_T = \frac{R_{25}}{\exp \left[B_{25/85} \left(\frac{1}{T_{25}} - \frac{1}{T} \right) \right]} \quad \text{T: Th}$$

T: Thermistor temperature R_T : Thermistor value at T

SP1 Package outline (dimensions in mm)

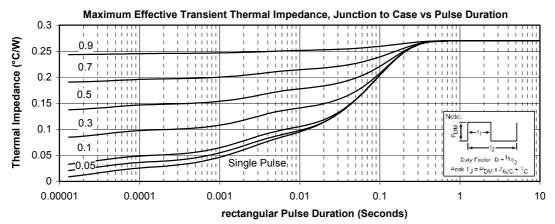


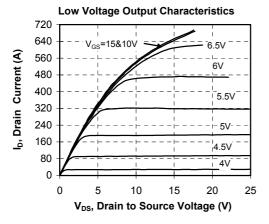
See application note 1904 - Mounting Instructions for SP1 Power Modules on www.microsemi.com

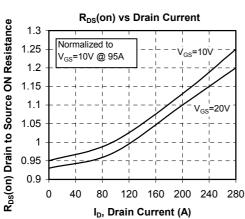
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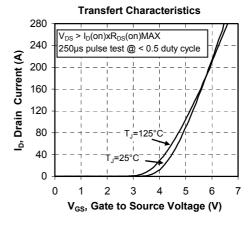


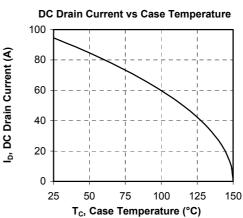
Typical CoolMOS Performance Curve



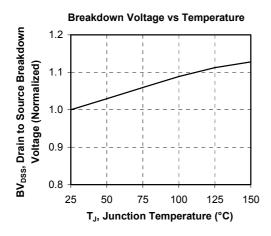


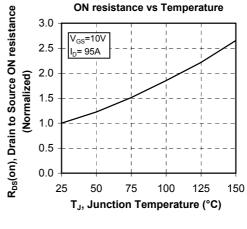


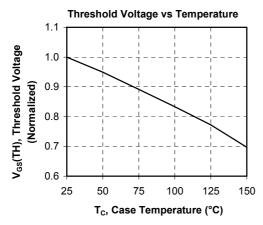


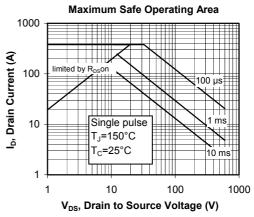


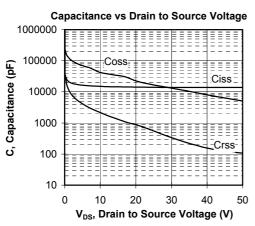


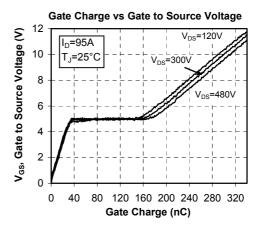




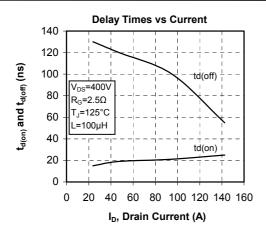


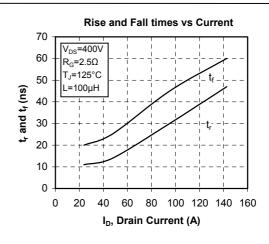


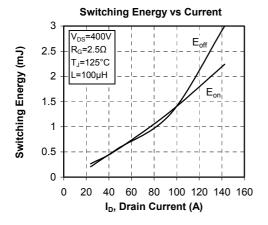


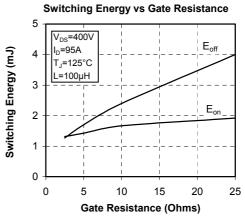


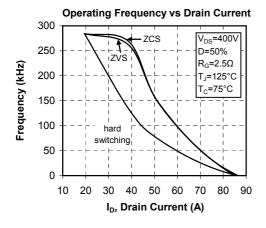


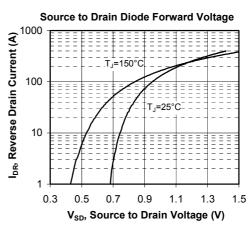






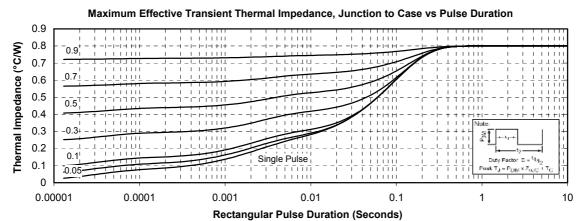


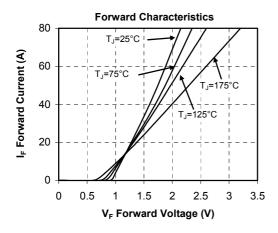


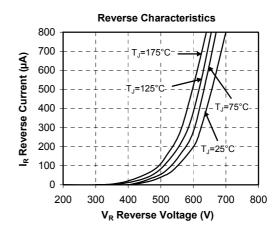


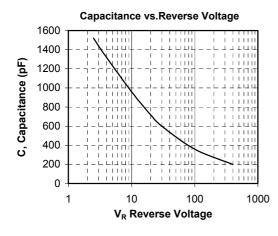


Typical CR2 SiC Diode Performance Curve









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